



# TEST REPORT

No.B19N01321-HAC RF

For

**Sun Cupid Technology (HK) Ltd.**

**LTE Mobile Phone**

**Model Name: S2801L,NUU F4L,F4L**

With

**Hardware Version: V01**

**Software Version: S2801L-VZ-MV44-01**

**FCC ID: 2ADINS2801L**

**Issued Date: 2019-07-30**

**Designation Number: CN1210**

**Note:**

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of SAICT.

**Test Laboratory:**

Shenzhen Academy of Information and Communications Technology  
Building G, Shenzhen International Innovation Center, No.1006 Shennan Road, Futian District,  
Shenzhen, Guangdong, P. R. China 518026.

Tel: +86(0)755-33322000, Fax: +86(0)755-33322001

Email: [yewu@caict.ac.cn](mailto:yewu@caict.ac.cn), website: [www.cszit.com](http://www.cszit.com)



**Picture 1: Front side of the sample**



**Picture 2: Back side of the sample**

HAC Test Setup Photographs

